

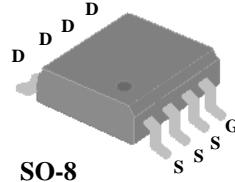


▼ Simple Drive Requirement

▼ Low On-resistance

▼ Fast Switching Characteristic

▼ RoHS Compliant

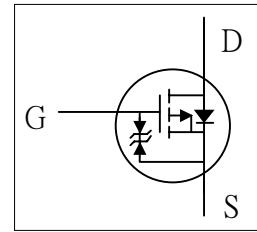


BV_{DSS}	-35V
$R_{DS(ON)}$	7.5mΩ
I_D	-14.5A

Description

Advanced Power MOSFETs from APEC provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SO-8 package is widely preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.

**Absolute Maximum Ratings@ $T_j=25^\circ\text{C}$ (unless otherwise specified)**

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	-35	V
V_{GS}	Gate-Source Voltage	+20	V
$I_D @ T_A=25^\circ\text{C}$	Drain Current ^{3a} , $V_{GS} @ 10\text{V}$	-14.5	A
$I_D @ T_A=70^\circ\text{C}$	Drain Current ^{3a} , $V_{GS} @ 10\text{V}$	-12	A
I_{DM}	Pulsed Drain Current ¹	-50	A
$P_D @ T_A=25^\circ\text{C}$	Total Power Dissipation	2.5	W
	Linear Derating Factor	0.02	W/ $^\circ\text{C}$
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
T_J	Operating Junction Temperature Range	-55 to 150	$^\circ\text{C}$

Thermal Data

Symbol	Parameter	Value	Unit
R _{thj-a}	Maximum Thermal Resistance, Junction-ambient ^{3a}	50	$^\circ\text{C}/\text{W}$

THIS PRODUCT IS SENSITIVE TO ELECTROSTATIC DISCHARGE, PLEASE HANDLE WITH CAUTION.

USE OF THIS PRODUCT AS A CRITICAL COMPONENT IN LIFE SUPPORT OR OTHER SIMILAR SYSTEMS IS NOT AUTHORIZED.

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Electrical Characteristics@ $T_j=25^\circ\text{C}$ (unless otherwise specified)

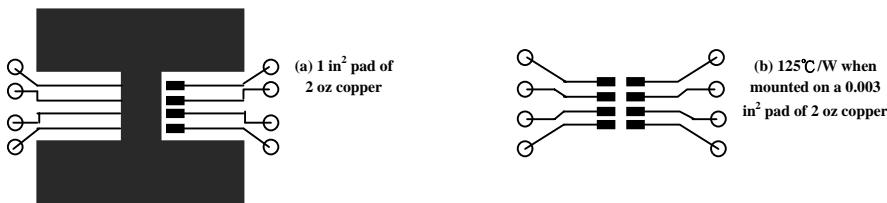
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=-250\mu\text{A}$	-35	-	-	V
$R_{\text{DS}(\text{ON})}$	Static Drain-Source On-Resistance ²	$V_{\text{GS}}=-10\text{V}, I_{\text{D}}=-7\text{A}$	-	-	7.5	$\text{m}\Omega$
		$V_{\text{GS}}=-4\text{V}, I_{\text{D}}=-7\text{A}$	-	-	15	$\text{m}\Omega$
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=-250\mu\text{A}$	-1	-	-3	V
g_{fs}	Forward Transconductance	$V_{\text{DS}}=-10\text{V}, I_{\text{D}}=-7\text{A}$	-	7	-	S
I_{DSS}	Drain-Source Leakage Current	$V_{\text{DS}}=-30\text{V}, V_{\text{GS}}=0\text{V}$	-	-	-10	μA
	Drain-Source Leakage Current ($T_j=70^\circ\text{C}$)	$V_{\text{DS}}=-24\text{V}, V_{\text{GS}}=0\text{V}$	-	-	-25	μA
I_{GSS}	Gate-Source Leakage	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	+30	μA
Q_g	Total Gate Charge ²	$I_{\text{D}}=-14\text{A}$	-	58	90	nC
Q_{gs}	Gate-Source Charge	$V_{\text{DS}}=-30\text{V}$	-	7	-	nC
Q_{gd}	Gate-Drain ("Miller") Charge	$V_{\text{GS}}=-4.5\text{V}$	-	37	-	nC
$t_{\text{d}(\text{on})}$	Turn-on Delay Time ²	$V_{\text{DS}}=-15\text{V}$	-	15	-	ns
t_r	Rise Time	$I_{\text{D}}=-1\text{A}$	-	13	-	ns
$t_{\text{d}(\text{off})}$	Turn-off Delay Time	$R_{\text{G}}=3.3\Omega$	-	76	-	ns
t_f	Fall Time	$V_{\text{GS}}=-10\text{V}$	-	60	-	ns
C_{iss}	Input Capacitance	$V_{\text{GS}}=0\text{V}$	-	4100	6600	pF
C_{oss}	Output Capacitance	$V_{\text{DS}}=-25\text{V}$	-	640	-	pF
C_{rss}	Reverse Transfer Capacitance	f=1.0MHz	-	530	-	pF

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V_{SD}	Forward On Voltage ²	$I_{\text{S}}=-14\text{A}, V_{\text{GS}}=0\text{V}$	-	-	-1.3	V
t_{rr}	Reverse Recovery Time ²	$I_{\text{S}}=-14\text{A}, V_{\text{GS}}=0\text{V},$ $dI/dt=100\text{A}/\mu\text{s}$	-	46	-	ns
			-	44	-	nC

Notes:

- 1.Pulse width limited by Max. junction temperature.
- 2.Pulse test
- 3.Surface mounted on 1 in² copper pad of FR4 board (a), t \leq 10sec



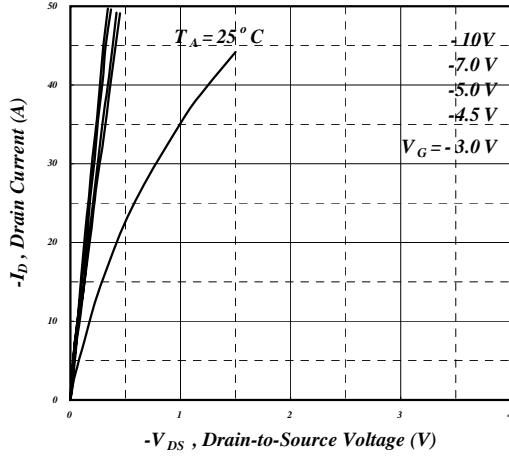


Fig 1. Typical Output Characteristics

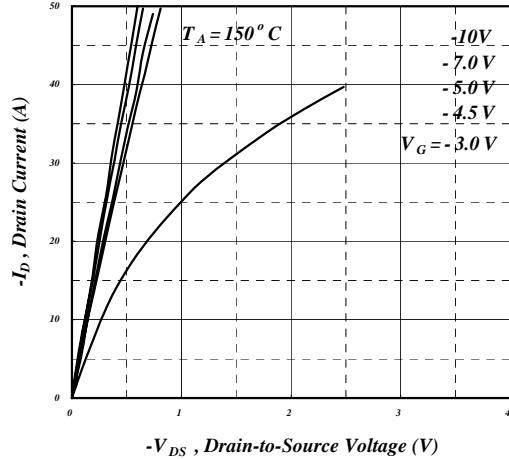


Fig 2. Typical Output Characteristics

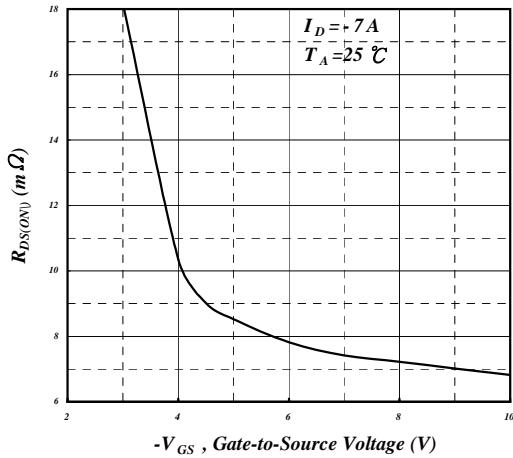


Fig 3. On-Resistance v.s. Gate Voltage

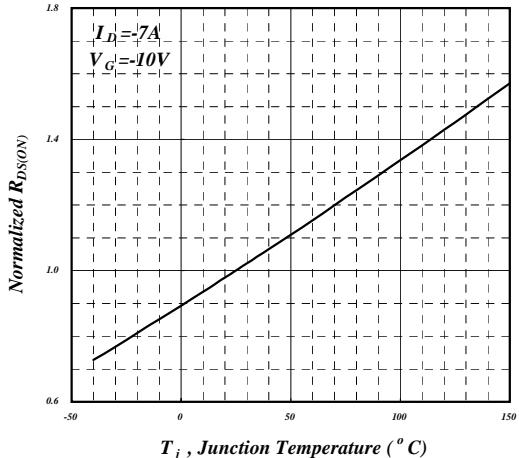


Fig 4. Normalized On-Resistance v.s. Junction Temperature

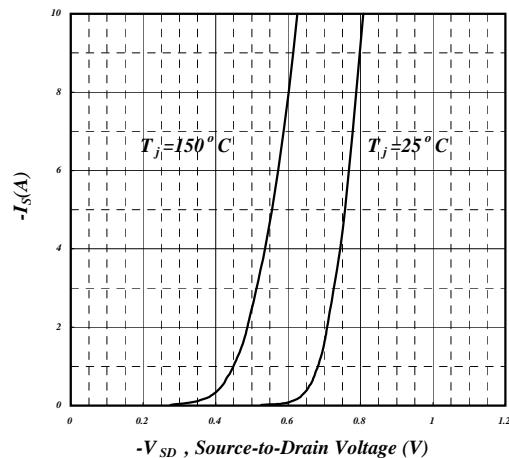


Fig 5. Forward Characteristic of Reverse Diode

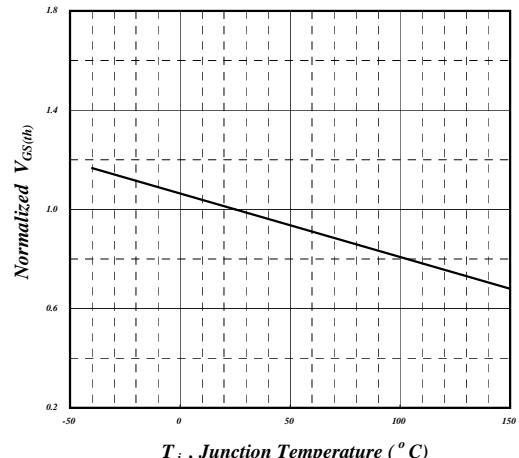
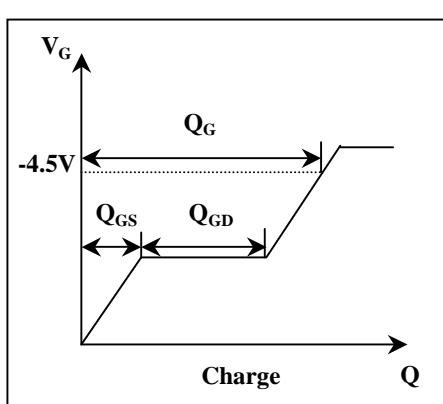
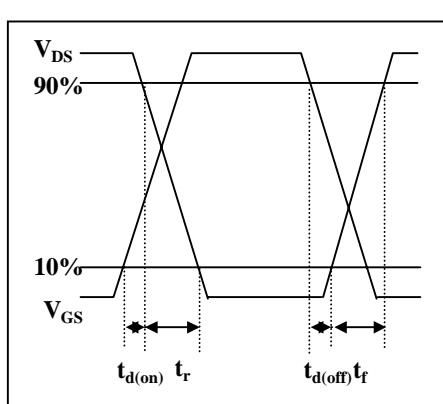
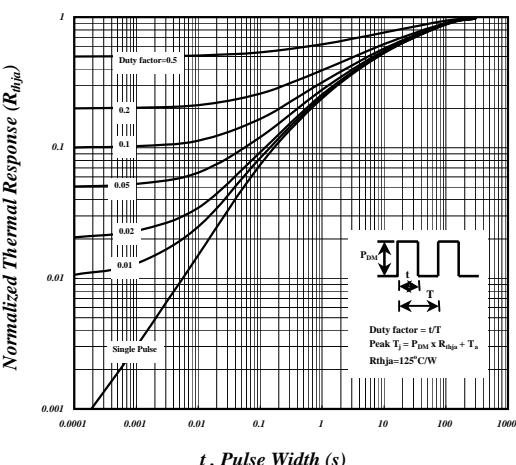
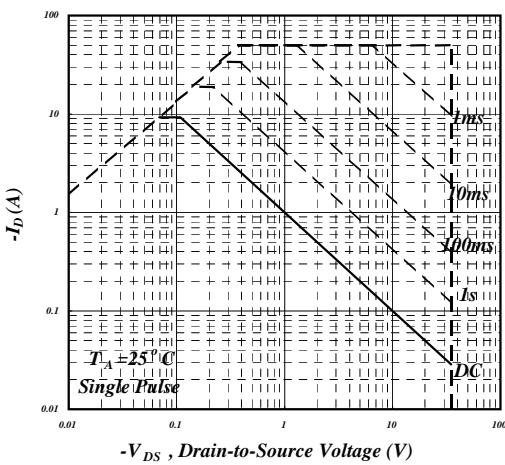
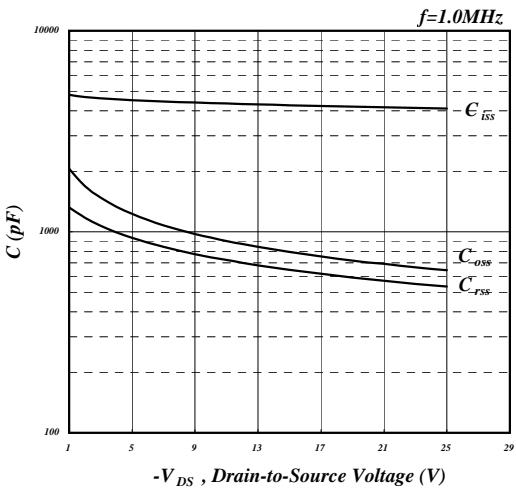
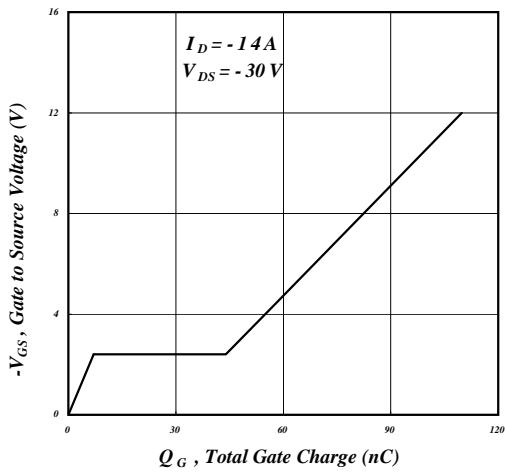
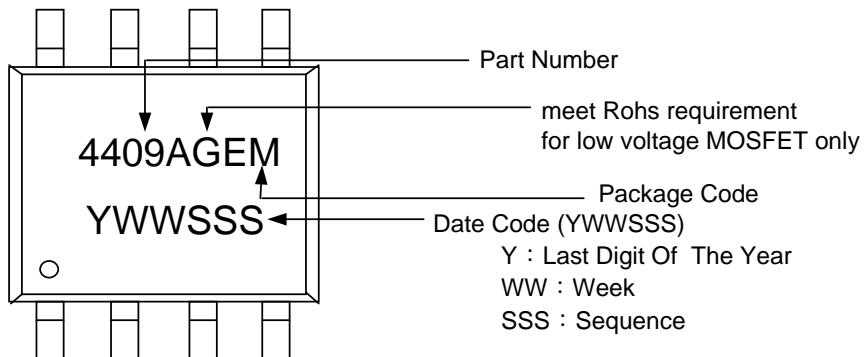


Fig 6. Gate Threshold Voltage v.s. Junction Temperature





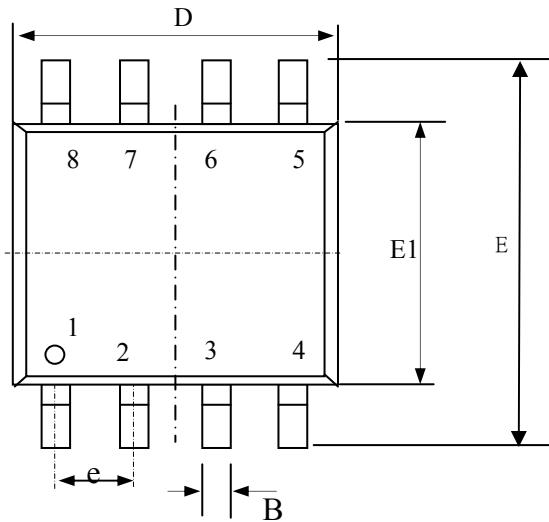
MARKING INFORMATION



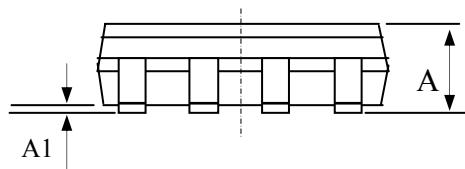


ADVANCED POWER ELECTRONICS CORP.

Package Outline : SO-8

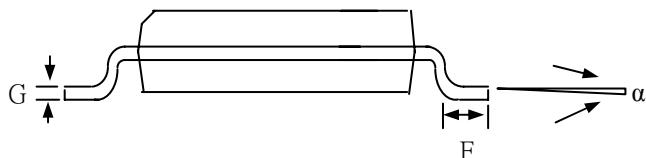


SYMBOLS	Millimeters		
	MIN	NOM	MAX
A	1.35	1.55	1.75
A1	0.05	0.15	0.25
B	0.30	0.41	0.51
D	4.80	5.05	5.30
E	5.79	6.00	6.20
E1	3.70	3.90	4.10
e	1.27 TYP		
G	0.17	0.21	0.25
F	0.38	0.83	1.27
α	0°	4°	8°



1. All Dimension Are In Millimeters.

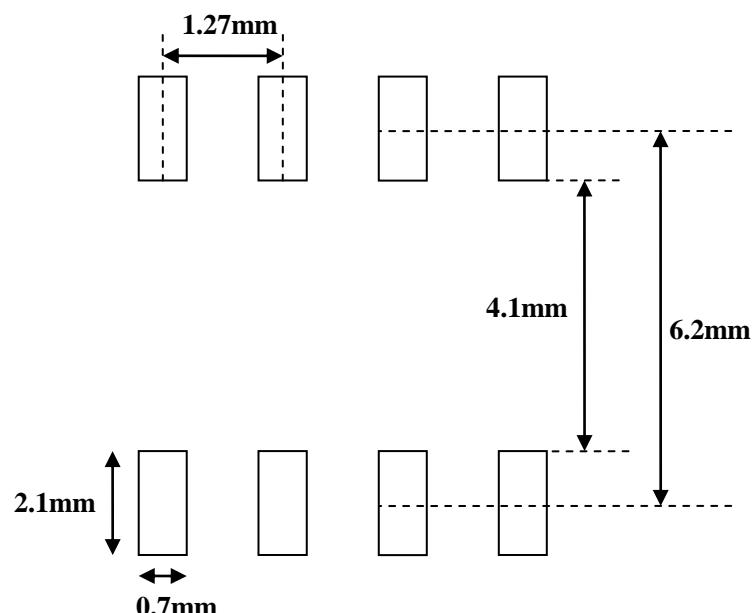
2. Dimension Does Not Include Mold Protrusions.



Draw No. M1-M8-G-v03



SO-8 FOOTPRINT :



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